TOSHIBA Power Transistor Module Silicon NPN Epitaxial Type (Four Darlington Power Transistor in One)

# **MP4301**

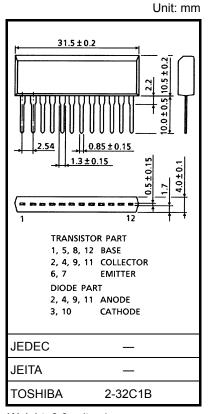
**High Power Switching Applications** 

Hammer Drive, Pulse Motor Drive and Inductive Load Switching

- Small package by full molding (SIP 12 pin)
- www.DataSheet U. High collector power dissipation (4 devices operation)
  - $: P_T = 4.4 \text{ W (Ta} = 25^{\circ}\text{C)}$
  - High collector current: IC(DC) = 3 A(max)
  - High DC current gain:  $h_{FE} = 2000$  (min) ( $V_{CE} = 2$  V,  $I_{C} = 1.5$  A)

#### **Absolute Maximum Ratings (Ta = 25°C)**

Characteristics		Symbol	Rating	Unit	
Collector-base voltage		$V_{CBO}$	120	V	
Collector-emitter voltage		V <sub>CEO</sub>	100	V	
Emitter-base voltage		V <sub>EBO</sub>	6	V	
Collector current	DC	Ic	3	Α	
	Pulse	I <sub>CP</sub>	6	A	
Continuous base current		ΙB	0.5	Α	
Collector power dissipation (1-device operation)		PC	2.2	W	
Collector power dissipation (4-device operation)		P <sub>T</sub>	4.4	W	
Junction temperature		Tj	150	°C	
Storage temperature range		T <sub>stg</sub>	−55 to 150	°C	



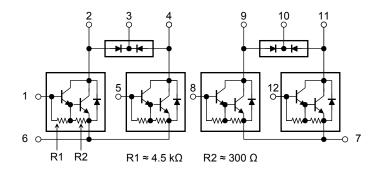
Weight: 3.9 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

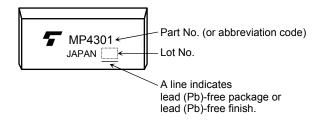
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).



### **Array Configuration**



# www.DataShee Marking



#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit	
Thermal resistance from junction to ambient	ΣR <sub>th (j-a)</sub>	28.4	°C/W	
(4-device operation, Ta = 25°C)	()/			
Maximum lead temperature for soldering purposes	TL	260	°C	
(3.2 mm from case for 10 s)	_			



# Electrical Characteristics (Ta = 25°C)

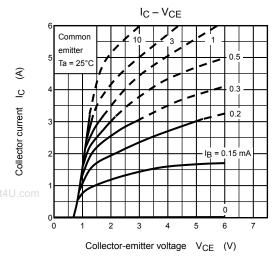
Charac	teristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off cu	rrent	I <sub>CBO</sub>	V <sub>CB</sub> = 120 V, I <sub>E</sub> = 0 A	_	_	10	μΑ
Collector cut-off cu	rrent	I <sub>CEO</sub>	V <sub>CE</sub> = 100 V, I <sub>B</sub> = 0 A	_	_	10	μΑ
Emitter cut-off curre	ent	I <sub>EBO</sub>	V <sub>EB</sub> = 6 V, I <sub>C</sub> = 0 A	0.5	_	2.5	mA
Collector-base brea	akdown voltage	V (BR) CBO	I <sub>C</sub> = 1 mA, I <sub>E</sub> = 0 A	120	_	_	V
Collector-emitter bi	reakdown voltage	V (BR) CEO	I <sub>C</sub> = 10 mA, I <sub>B</sub> = 0 A	100	_	_	V
DC summent spin		h <sub>FE (1)</sub>	V <sub>CE</sub> = 2 V, I <sub>C</sub> = 1.5 A	2000	_	15000	
DC current gain		h <sub>FE (2)</sub>	V <sub>CE</sub> = 2 V, I <sub>C</sub> = 3 A	1000	_	_	_
Saturation voltage	Collector-emitter	V <sub>CE</sub> (sat)	I <sub>C</sub> = 1.5 A, I <sub>B</sub> = 3 mA	_	_	1.5	V
	Base-emitter	V <sub>BE (sat)</sub>	I <sub>C</sub> = 1.5 A, I <sub>B</sub> = 3 mA	_	_	2.0	V
Transition frequence	cy .	f <sub>T</sub>	V <sub>CE</sub> = 2 V, I <sub>C</sub> = 0.5 A	_	60	_	MHz
Collector output ca	pacitance	C <sub>ob</sub>	V <sub>CB</sub> = 10 V, I <sub>E</sub> = 0 A, f = 1 MHz	_	30	_	pF
Switching time  Storage time  Fall time	t <sub>on</sub>	Output Input →	_	0.3	_		
	Storage time	t <sub>stg</sub>	20 μs I <sub>B2</sub> V <sub>CC</sub> = 30 V	_	2.0	_	μs
	Fall time	t <sub>f</sub>	$I_{B1} = -I_{B2} = 3 \text{ mA, duty cycle} \le 1\%$	_	0.4	_	

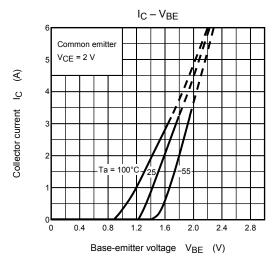
# **Emitter-Collector Diode Ratings and Characteristics (Ta = 25°C)**

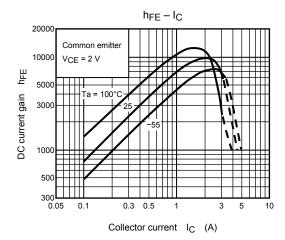
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Maximum forward current	I <sub>FM</sub>	_	_	_	3	Α
Surge current	I <sub>FSM</sub>	t = 1 s, 1 shot	_	_	6	Α
Forward voltage	V <sub>F</sub>	I <sub>F</sub> = 1 A, I <sub>B</sub> = 0 A	_	1.2	1.8	٧
Forward voltage	t <sub>rr</sub>	$I_F = 3 \text{ A}, V_{BE} = -3 \text{ V}, dI_F/dt = -50 \text{ A}/\mu\text{s}$	_	1.0	_	μs
Reverse recovery charge	Q <sub>rr</sub>		_	5	_	μC

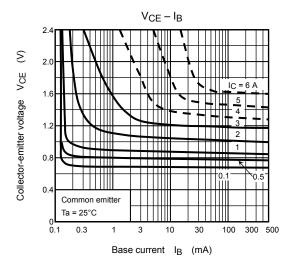
# Flyback-Diode Ratings and Characteristics (Ta = 25°C)

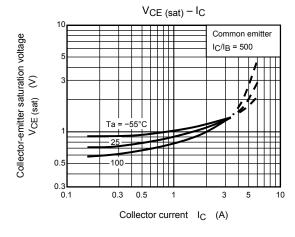
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Maximum forward current	I <sub>FM</sub>	_	_	_	3	Α
Reverse current	I <sub>R</sub>	V <sub>R</sub> = 120 V	_	_	0.4	μΑ
Reverse voltage	$V_{R}$	I <sub>R</sub> = 100 μA	120	_	_	V
Forward voltage	V <sub>F</sub>	I <sub>F</sub> = 0.5 A	ı	1	1.8	V

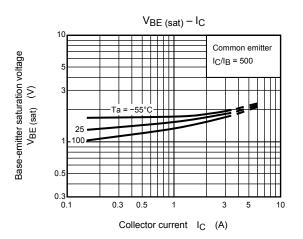


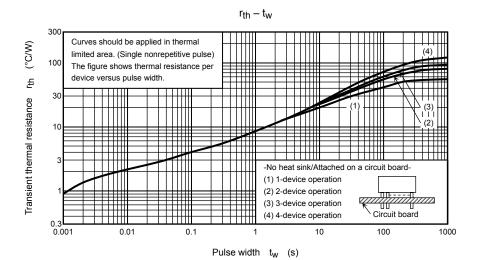




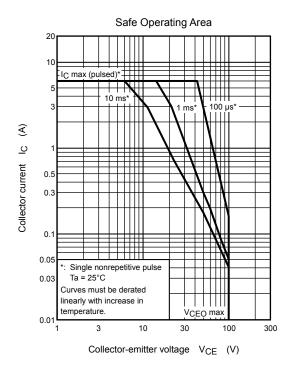


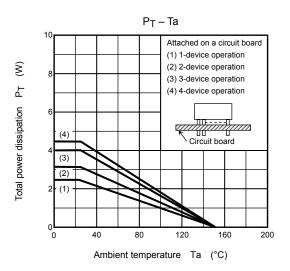


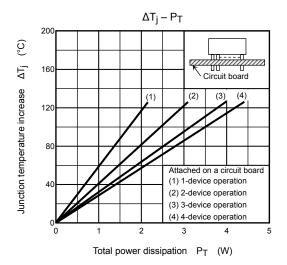




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